## NOTES:

1. SUBSTRATE:

Silicon (Si)

- 2. CENTERING TOLERANCE: EDGE THICKNESS VARIATION: <20µm
- 3. COATING (APPLY ACROSS CLEAR APERTURE)

S1&S2: NONE

				SPECIFIC	SECTION A-A <b>INFORMATION ONLY:</b> NOT MANUFACTURE STOTHIS DRAWING CATIONS SUBJECT TO CHANGE WITHOUT NOTICE IONS ARE FOR REFERENCE ONLY
	S1	S2	Г		_ (R)
SHAPE	CONVEX	CONCAVE			<sup>®</sup> Edmund Optics <sup>®</sup>
RADIUS	18.00	36.49			
SURFACE QUALITY	60-40	60-40			25.4mm Dia. x 12.7mm FL, Uncoated, ISP
CLEAR APERTURE	ø22.86	ø22.86	THIRD ANGLE	TITLE	Optics Silicon (Si) Aspheric Lens
IRREGULARITY AT 632.8nm BEVEL	λ/4 PROTECTED AS NEEDED	$\lambda/4$ PROTECTED AS NEEDED	ALL DIMS IN mm	DWG NO	24881 SHEET 1 OF 19